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INTERNATIONAL STANDARD



Fibre optic interconnecting devices and passive components – Basic test and measurement procedures –

Part 2-22: Tests – Change of temperature

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INTERNATIONAL **STANDARD**



Fibre optic interconnecting devices and passive components - Basic test and measurement procedures –
Part 2-22: Tests – Change of temperature

INTERNATIONAL ELECTROTECHNICAL COMMISSION

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

FIBRE OPTIC INTERCONNECTING DEVICES AND PASSIVE COMPONENTS – BASIC TEST AND MEASUREMENT PROCEDURES –

Part 2-22: Tests - Change of temperature

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This commented version (CMV) of the official standard IEC 61300-2-22:2024 edition 3.0 allows the user to identify the changes made to the previous IEC 61300-2-22:2007 edition 2.0. Furthermore, comments from IEC SC 86B experts are provided to explain the reasons of the most relevant changes, or to clarify any part of the content.

A vertical bar appears in the margin wherever a change has been made. Additions are in green text, deletions are in strikethrough red text. Experts' comments are identified by a blue-background number. Mouse over a number to display a pop-up note with the comment.

This publication contains the CMV and the official standard. The full list of comments is available at the end of the CMV.

IEC 61300-2-22 has been prepared by subcommittee 86B: Fibre optic interconnecting devices and passive components, of IEC technical committee 86: Fibre optics. It is an International Standard.

This third edition cancels and replaces the second edition published in 2007. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) include a passive component, patch cord, splices, fibre management system or protective housing to withstand the effects of a change of temperature or a succession of changes of temperature into the project scope;
- b) update the severity categories description, number of cycles, and duration of the extremes in Table 1 to be in line with IEC 61753-1.

The text of this International Standard is based on the following documents:

Draft	Report on voting
86B/4904/FDIS	86B/4931/RVD

Full information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this International Standard is English.

This document was drafted in accordance with ISO/IEC Directives, Part 2, and developed in accordance with ISO/IEC Directives, Part 1 and ISO/IEC Directives, IEC Supplement, available at www.iec.ch/members_experts/refdocs. The main document types developed by IEC are described in greater detail at www.iec.ch/publications.

A list of all parts of the IEC 61300 series, published under the general title *Fibre optic* 2024 interconnecting devices and passive components – Basic test and measurement procedures, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under webstore.iec.ch in the data related to the specific document. At this date, the document will be

- reconfirmed,
- withdrawn, or
- revised.

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FIBRE OPTIC INTERCONNECTING DEVICES AND PASSIVE COMPONENTS – BASIC TEST AND MEASUREMENT PROCEDURES –

Part 2-22: Tests - Change of temperature

1 Scope

This part of IEC 61300 describes a procedure to determine the suitability of a fibre optic interconnecting device and a passive component 1 to withstand the effects of a change of temperature or a succession of changes of temperature.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60068-2-14, Basic Environmental testing procedures – Part 2-14: Tests – Test N: Change of temperature

IEC 60529, Degrees of protection provided by enclosures (IP Code)

IEC 61300-1, Fibre optic interconnecting devices and passive components – Basic test and measurement procedures – Part 1: General and guidance

IEC 61300-2-38, Fibre optic interconnecting devices and passive components – Basic test and measurement procedures – Part 2-38: Tests – Sealing for pressurized fibre optic closures

IEC 61300-3-1, Fibre optic interconnecting devices and passive components – Basic test and measurement procedures – Part 3-1: Examinations and measurements – Visual examination

IEC 61300-3-3, Fibre optic interconnecting devices and passive components – Basic test and measurement procedures – Part 3-3: Examinations and measurements – Active monitoring of changes in attenuation and return loss

IEC 61300-3-4, Fibre optic interconnecting devices and passive components – Basic test and measurement procedures – Part 3-4: Examinations and measurements – Attenuation

IEC 61300-3-6, Fibre optic interconnecting devices and passive components – Basic test and measurement procedures – Part 3-6: Examinations and measurements – Return loss 2

IEC 61753 (all parts), Fibre optic interconnecting devices and passive components – Performance standard

IEC 62005 (all parts), Reliability of fibre optic interconnecting devices and passive components

3 Terms and definitions 3

For the purposes of this document, the terms and definitions given in IEC 61300-1 apply.

ISO and IEC maintain terminology databases for use in standardization at the following addresses:

- IEC Electropedia: available at https://www.electropedia.org/
- ISO Online browsing platform: available at https://www.iso.org/obp

4 General description

This procedure is conducted in accordance with IEC 60068-2-14, test Nb, change of temperature with specified rate of change.

The device under test (DUT) is first subjected to one extreme of temperature for a given period of time. It is then subjected to the other extreme of temperature for an equal period of time. It can be subjected to one or more changes of temperatures defined by the temperature profile and the number of cycles.

5 Apparatus

The apparatus consists of suitable environmental chambers in accordance with IEC 60068-2-14, test Nb.

The rate of change of temperature shall be: (1 ± 0,2) °C/min. 4

5.1 Environmental test chamber

A suitable environmental test chamber shall be used in accordance with IEC 60068-2-14, Test Nb.

5.2 Examination and measurement equipment

Suitable examination and optical measurement equipment shall be used in accordance with IEC 60529, IEC 61300-2-38, IEC 61300-3-1, IEC 61300-3-3, IEC 61300-3-4, or IEC 61300-3-6 as required by the relevant IEC 61753 series performance standard or IEC 62005 series reliability document. **5**

6 Procedure

6.1 General

The procedure is in accordance with IEC 60068-2-14, Test Nb.

Unless otherwise stated in the relevant specification:

- include 1,5 m of cable in the climatic chamber for each port monitored during the test;
- if optical measurements are requested during the test by the relevant specification, these measurements shall be performed (at a minimum) at the end of each dwell at each temperature extreme;
- allow dependence on wavelength scan time for components that require wavelength scanning.

6.2 Preconditioning

Unless otherwise stated in the relevant specification, 7 Maintain the DUT under standard atmospheric conditions as defined in IEC 61300-1 for at least 2 h. For large devices such as protective housings, the duration shall be at least 4 h 8. Clean the mechanical and optical alignment parts of the DUT according to the manufacturer's instructions.

NOTE Cleaning method for optical connector and optical transceiver are described in IEC TR 62627-01 and IEC TR 62572-4, respectively.

6.3 Initial examination and measurement

Perform initial examinations and measurements as required in the relevant—specification IEC 61753 series performance standard or IEC 62005 series reliability document.

6.4 Testing DUT

Place the specimen DUT in the environmental test chamber in its normal operating position and make connections to the monitoring equipment. Test sample configuration in the chamber shall be according to IEC 61300-1. 10

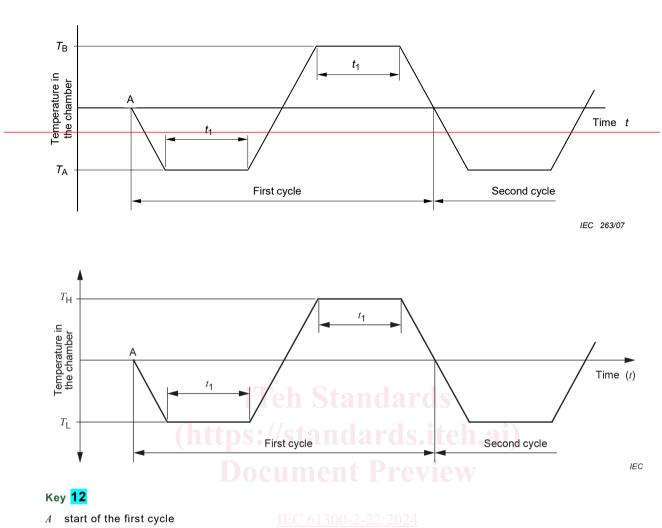
6.5 Examination and measurement during test

Perform all examinations and measurements during the test as required by the relevant IEC 61753 series performance standard or IEC 62005 series reliability document. The following applies:

- These measurements shall be performed (at a minimum) at the end of each dwell at each temperature extreme before starting the temperature change. Use a maximum measurement period of 10 min between optical measurements during the performance test.
- Allow dependence on wavelength scan time for components that require wavelength scanning.

6.6 Test conditions

Unless otherwise specified, the temperature profile in Figure 1 shall be applied. Start at standard atmospheric conditions and ramp down to the low temperature—at 1 °C/min T_L . Maintain the low temperature during t_1 for a minimum of 1 h. Ramp up to the high temperature T_E at 1 °C/min T_H . Maintain the temperature during t_1 for a minimum of 1 h. Ramp down to the low temperature and repeat this profile for the required number of cycles. The rate of change of temperature shall be (1 ± 0.2) °C/min. For larger devices, such as protective housings, the dwell time, t_1 , shall be a minimum of 4 h. 11



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 $T_{\rm H}$ high chamber temperature

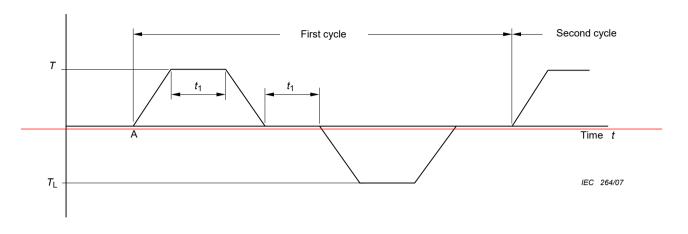
t₄ dwell time

Figure 1 - Temperature profile

NOTE—It is permissible to increase the dwell time at each extreme to allow sufficient time to perform a complete set of measurements.

5.3.3 Optional cycle: for some performance categories, it may be necessary to ramp to the high temperature first and include a dwell at room temperature between ramps to the extreme temperatures. In this case, the profile in Figure 2 shall be applied.

Start at standard atmospheric conditions and ramp up to the high temperature T at 1 °C/min. Then maintain the high temperature during t_4 for a minimum of 60 min. Ramp down to standard atmospheric conditions at 1 °C/min. Maintain standard atmospheric conditions for a minimum of 60 min. Ramp down to the low temperature T_L at 1 °C/min. Maintain that temperature during t_4 for a minimum of 60 min. Ramp up to standard atmospheric conditions at 1 °C/min and dwell for a minimum of 60 min. The subsequent cycles will have the same pattern.



A = start of first cycle

Figure 2 - Optional temperature profile 13

6.7 Recovery

Allow the specimen to remain under standard atmospheric conditions for a period of at least 2 h.

Unless otherwise stated, maintain the DUT under standard atmospheric conditions as defined in IEC 61300-1 for at least 2 h. For large devices such as protective housings, the duration shall be at least 4 h.

6.8 Final examinations and measurements

Record final measurements as required by the relevant specification. Unless otherwise specified in the relevant specification, clean the DUT according to the manufacturer's instructions prior to recording final measurements.

Perform final examinations and measurements as required in the relevant IEC 61753 series performance standard or IEC 62005 series reliability document. 14

7 Severity

Table 1 shows the specified test severities in relation to the performance categories. It is recommended to verify the test severities with the relevant IEC 61753 series performance standards and IEC 62005 series reliability documents for the normative values. 15

Each of the following severities is defined by a combination of a low temperature with the corresponding high temperature exposure and the corresponding number of cycles. One of them shall be specified in the relevant specification: